

Silicon Carbide Schottky Diode

QSD-HCS030X120

Features

- 1200v schottky rectifier
- Zero reverse recovery current
- High-frequency operation
- Temperature-independent switching behavior
- Extremely fast switching

V _{rrm} =	1200 V
I _f (T _c =150°C)	30 A
Q _c =	154 nC

Benefits

- Replace bipolar with unipolar rectifiers
- Essentially no switching losses
- Higher efficiency
- Reduction of heat sink requirements
- Parallel devices without thermal runaway

Package



Applications

- Switch mode power supplies (SMPS)
- Power factor correction
- Motor drives

Part Number	Package	Marking
QSD-HCS030X120	Die Only	Q

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Maximum Rated Values (Tc=25°C unless otherwise specified)

Symbol	Parameter	Value	Unit	Test Conditions	Note
Vrrm	Repetitive Peak Reverse Voltage	1200	V		
If	Continuous Forward Current	80	A	Tc=25°C	Fig.3
		43		Tc=135°C	
		30		Tc=150°C	
Ifrm	Repetitive Peak Forward Surge Current	135	A	Tc=25°C, Tp=10ms, Half Sine Pulse	
		100		Tc=110°C, Tp=10ms, Half Sine Pulse	
Ifsm	Non-Repetitive Forward Surge Current	190	A	Tc=25°C, Tp=10ms, Half Sine Pulse	
		166		Tc=110°C, Tp=10ms, Half Sine Pulse	
Ptot	Power Dissipation	454	W	Tc=25°C	Fig.4
		197		Tc=110°C	
Tj	Operating Temperature	-55 to +175	°C		
Tstg	Storage Temperature	-55 to +175	°C		

Electrical Characteristics (Tj=25°C)

Symbol	Parameter	Value			Unit	Test Conditions	Note
		Min.	Typ.	Max.			
Vf	Forward Voltage		1.5	1.8	V	If=30A, Tj=25°C	Fig.1
			2.0	3		If=30A, Tj=175°C	
Ir	Reverse Current		15	250	µA	Vr=1200V, Tj=25°C	Fig.2
			208	450		Vr=1200V, Tj=175°C	
Qc	Total Capacitive Charge		154		nC	Vr=800V, Tj=25°C	Fig.5
C	Total Capacitance		2425		pF	Vr=0V, Tj=25°C, f=1MHz	Fig.6
			138			Vr=400V, Tj=25°C, f=1MHz	
			133			Vr=800V, Tj=25°C, f=1MHz	
Ec	Capacitance Stored Energy		38		µJ	Vr=800V	Fig.7

Thermal Characteristics

Symbol	Parameter	Value	Unit	Note
Rejc	Thermal Resistance (Junction to Case) ¹	0.33	°C/W	Fig.8

Typical Performance

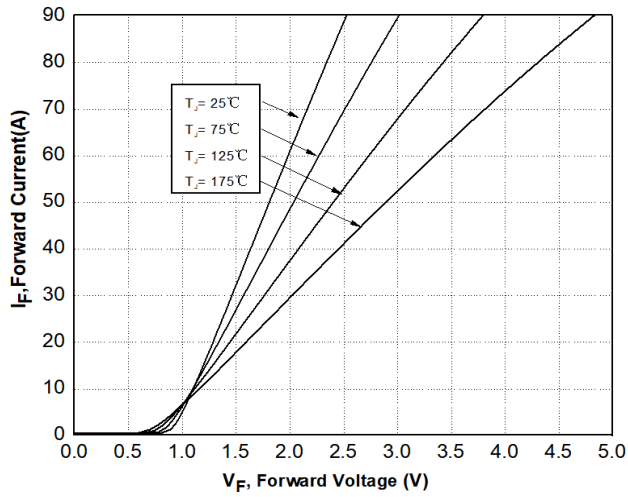


Figure 1. Forward Characteristics

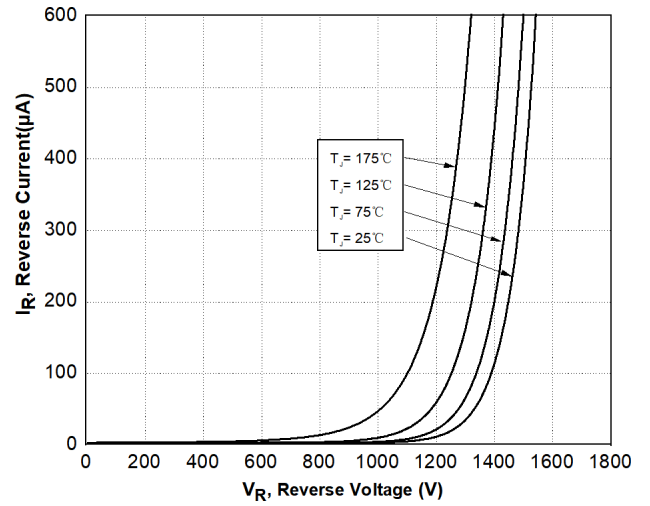


Figure 2. Reverse Characteristics

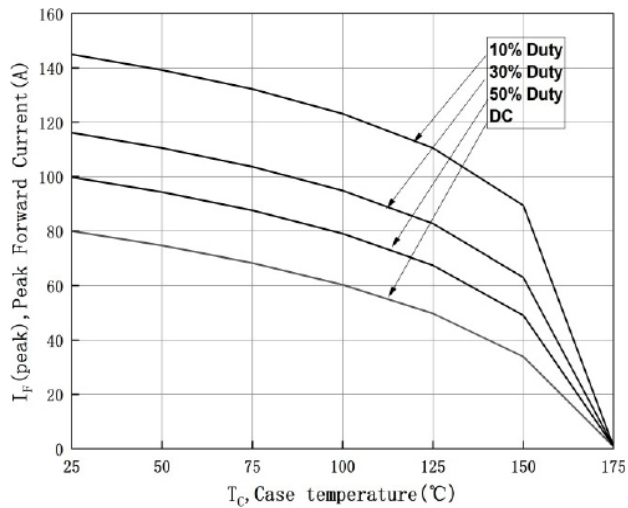


Figure 3. Current Derating

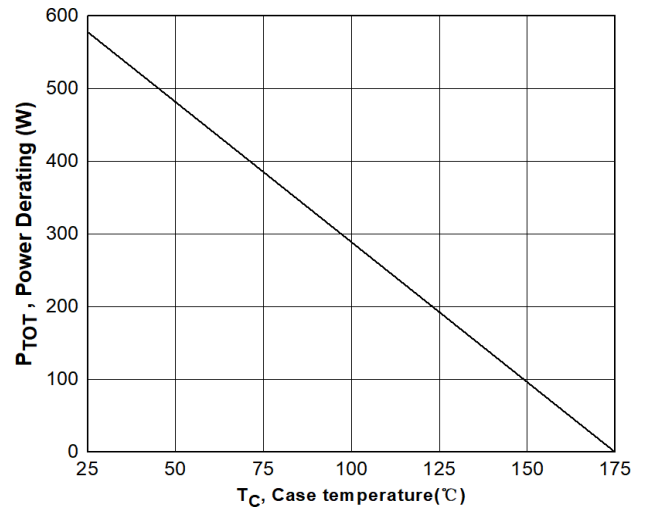


Figure 4. Power Derating

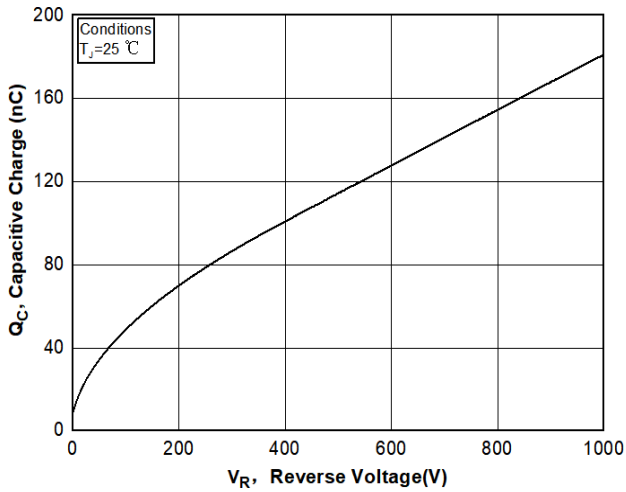


Figure 5. Capacitance Charge Vs. Reverse Voltage

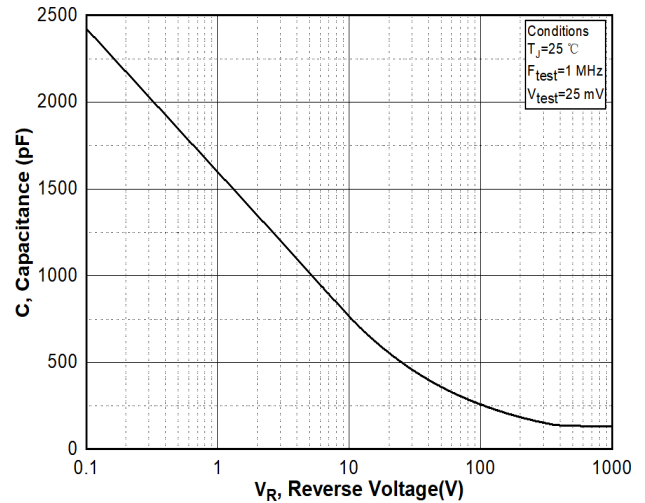


Figure 6. Capacitance Vs. Reverse Voltage

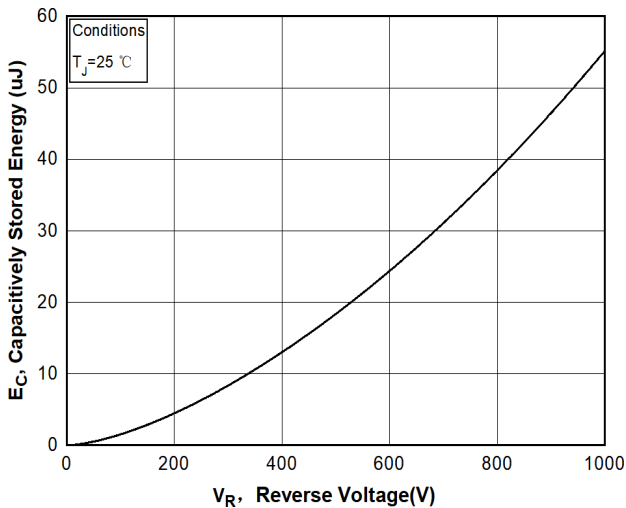


Figure 7. Capacitance Stored Energy

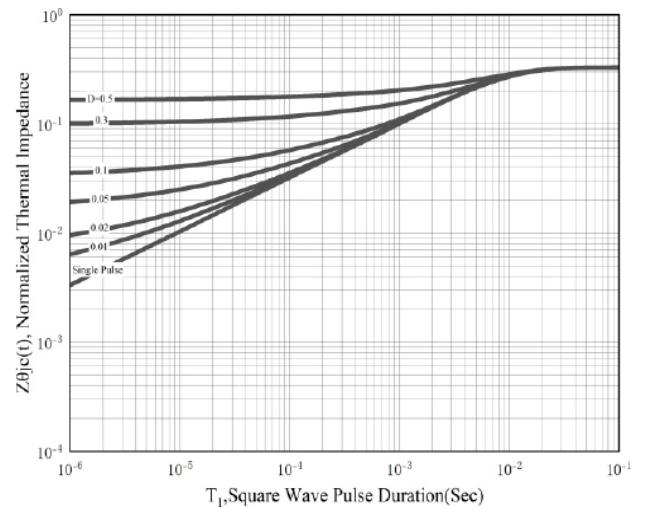
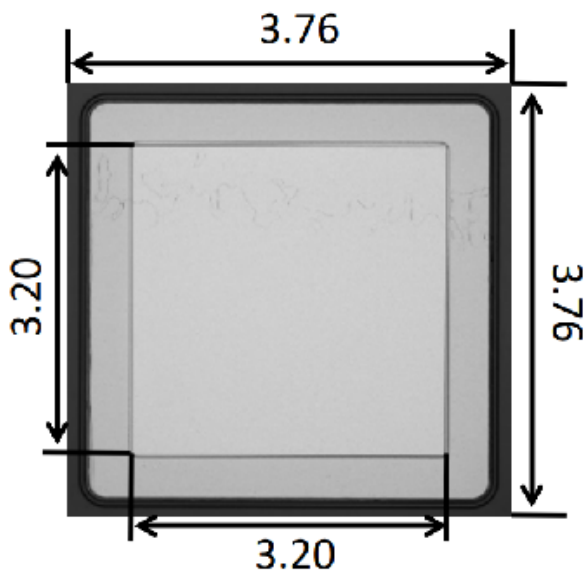


Figure 8. Transient Thermal Response Curve(Junction-to-Case)

Package Dimensions



Product Dimensions

Parameter	Typical	Units
Die Size(LxW)	3.76x3.76	mm
Anode Pad Opening	3.20x3.20	mm
DieThickness ¹	364±10%	µm
Top side Anode Metalization (Al)	4	µm
Back side Cathode Metalization (Ni/Ti/Ag)	2.05	µm
Front side Passivation (polymide)	SiO ₂ Polyimide	

Attention

- Specifications of any and all products described or contained herein stipulate the performance, characteristics, and functions of the described products in the independent state, and are not guarantees of the performance, characteristics, and functions of the described products as mounted in the customer's products or equipment. To verify symptoms and states that cannot be evaluated in an independent device, the customer should always evaluate and test devices mounted in the customer's products or equipment.
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